

**Search Notes**

Application/Control No.

10/587,142

Examiner

Tan V. Mai

Applicant(s)/Patent under  
Reexamination

LONN, MARKUS

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
updated	search	1/25/2010	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>708</b>	<b>405</b>	1/25/2010	<b>MAI</b>
PGPUB text search (see interference search printout)		1/25/2010	MAI

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search (see printout)	1/25/2010	MAI